

Notice of References Cited	Application/Control No. 10/550,610		Applicant(s)/Patent Under Reexamination SPAANS ET AL.	
	Examiner John Freeman		Art Unit 1794	Page 1 of 1

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*	B	US-2002/0045051 A1	04-2002	Fujii et al.	428/458
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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